

FORM HDP-1449 (Based on Form PTO-1449)		ATTORNEY DOCKET No.	SERIAL NO.
		1740-000044/US	10/762,536
PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION SEP 11 2008 (Use several sheets if necessary)		APPLICANT	
		Sang Woon SUH et al.	
Sheet 1 of 4		FILING DATE	GROUP
		January 23, 2004	2132

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/Subclass	(If appropriate) Filing Date
		US 4,879,707	11/07/1989	GETREUER et al.		
		US 5,295,127	03/15/1994	VERBOOM et al.		
		US 5,572,507	11/05/1996	OZAKI et al.		
		US 5,706,268	01/06/1998	HORIMAI		
		US 5,799,501	09/01/1998	LEONARD et al.		
		US 5,818,805	10/06/1998	KOBAYASHI et al.		
		US 5,848,050	12/08/1998	NAGASAWA et al.		
		US 5,878,007	03/02/1999	MATSUMOTO et al.		
		US 5,894,463	04/13/1999	OKAWA et al.		
		US 6,031,815	02/29/2000	HEEMSKERK		
		US 6,223,247	04/24/2001	OTSUKA et al.		
		US 6,223,285	04/24/2001	KOMURO et al.		
		US 6,289,102	09/11/2001	UEDA et al.		
		US 6,549,495	04/15/2003	SPRUIT et al.		
		US 6,885,629	04/26/2005	OSHIMA et al.		
		US 6,930,977	08/16/2005	KONDO et al.		
		US 7,266,074	09/04/2007	KIM et al.		
		US 2001/0036132	11/01/2001	KOBAYASHI et al.		
		US 2002/0041686	04/11/2002	MORIYAMA et al.		
		US 2002/0089920	07/11/2002	GOTOH et al.		
		US 2002/0181358	12/05/2002	SAKO		
		US 2003/0007432	01/09/2003	MINAMINO et al.		
		US 2003/0012375	01/16/2003	SAKO et al.		
		US 2003/0053404	03/20/2003	KONDO		
		US 2004/0076110	04/22/2004	HINO et al.		
		US 2004/0120247	06/24/2004	LEE et al.		

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Sheet 2 of 4		FILING DATE	GROUP
		January 23, 2004	2132

		US 2004/0151091	08/05/2004	MA et al.		
		US 2005/0018555	01/27/2005	SABI et al.		
		US 2005/0099916	05/12/2005	JEON et al.		
		US 2005/0122889	06/09/2005	KOBAYASHI et al.		

FOREIGN PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/Subclass	Translation Yes      No
		EP 0 299 573	10/27/1993	EUROPE		X
		EP 0 545 472	06/09/1993	EUROPE		X
		EP 0 807 929	11/19/1997	EUROPE		X
		EP 0 936 610	08/18/1999	EUROPE		X
		EP 1 028 423	09/16/2000	EUROPE		X
		EP 1 058 254	12/06/2000	EUROPE		X
		EP 1 122 729	08/08/2001	EUROPE		X
		EP 1 168 312	01/02/2002	EUROPE		X
		EP 1 229 537	08/07/2002	EUROPE		X
		JP 05-325193	12/10/1993	JAPAN	Abstract	
		JP 07-272282	10/20/1995	JAPAN	Abstract	
		JP 08-124171	05/17/1996	JAPAN	Abstract	
		JP 08-147704	06/07/1996	JAPAN	Abstract	
		JP 09-081938	03/28/1997	JAPAN	Abstract	
		JP 09-128874	05/16/1997	JAPAN	Abstract	
		JP 10-003746	01/06/1998	JAPAN	Abstract	
		JP 10-269577	10/09/1998	JAPAN	Abstract	
		JP 11-086436	03/30/1999	JAPAN	Abstract	
		JP 11-317002	11/16/1999	JAPAN	Abstract	

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**PATENT AND TRADEMARK OFFICE  
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Sheet 3 of 4

		JP 2000-149415	05/30/2000	JAPAN		Abstract	
		JP 2000-195049	07/14/2000	JAPAN		Abstract	
		JP 2000-195094	07/14/2000	JAPAN		Abstract	
		JP 2000-298941	10/24/2000	JAPAN		Abstract	
		JP 2001-243355	09/07/2001	JAPAN		Abstract	
		JP 2001-256678	09/21/2001	JAPAN		Abstract	
		JP 2001-332031	11/30/2001	JAPAN		Abstract	
		JP 2002-042347	02/08/2002	JAPAN		Abstract	
		JP 2002-163857	06/07/2002	JAPAN		Abstract	
		JP 2002-197674	07/12/2002	JAPAN		Abstract	
		JP 2002-197789	07/12/2002	JAPAN		Abstract	
		JP 2002-304809	10/18/2002	JAPAN		Abstract	
		JP 2003-006997	01/10/2003	JAPAN		Abstract	
		KR 2004-0048476	06/10/2004	KOREA		Abstract	
		WO 97/45836	12/04/1997	WIPO			X
		WO 00/21085	04/13/2000	WIPO			X
		WO 02/15183	02/21/2002	WIPO			X
		WO 2004/095439	11/04/2004	WIPO			X
		WO 2004/066286	08/05/2004	WIPO			X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	
		International Search Report dated May 6, 2004.
		International Search Report dated May 18, 2004.
		International Search Report dated May 18, 2004.
		Korean Office Action dated March 28, 2005.

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	Korean Office Action dated March 30, 2006.
	European Search Report dated June 12, 2006.
	European Search Report dated September 22, 2006.
	European Search Report dated September 22, 2006.
	European Search Report dated November 24, 2006.
	Russian Office Action dated January 30, 2007.
	Taiwanese Office Action dated July 10, 2007.
	Japanese Office Action dated August 24, 2007.
	European Search Report dated October 29, 2007.
	European Search Report dated November 7, 2007.
	Japanese Office Action dated January 16, 2008.
	Japanese Office Action dated January 16, 2008.
	Japanese Office Action dated January 16, 2008.
	Japanese Office Action dated January 16, 2008.
	European Search Report dated March 12, 2008.
	Japanese Office Action dated March 17, 2008.
	Japanese Office Action dated March 24, 2008.
	European Search Report dated March 26, 2008.
	European Search Report dated April 2, 2008.

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